



Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN5d041**

Communication System: CW-1900; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL 1900 MHz;

Medium parameters used:  $f = 1900$  MHz;  $\sigma = 1.47$  mho/m;  $\epsilon_r = 38.8$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: Flat Section

Measurement Standard: DASy4 (High Precision Assessment)

DASy4 Configuration:

- Probe: ET3DV6 - SN1507; ConvF(4.96, 4.96, 4.96); Calibrated: 1/23/2004
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE3 Sn411; Calibrated: 11/6/2003
- Phantom: SAM with CRP - TP1006; Type: SAM 4.0; Serial: TP:1006;
- Measurement SW: DASy4, V4.2 Build 30; Postprocessing SW: SEMCAD, V1.8 Build 98

**Pin = 250 mW; d = 10 mm/Area Scan (81x81x1):** Measurement grid: dx=15mm, dy=15mm

Reference Value = 93.8 V/m

Power Drift = 0.002 dB

Maximum value of SAR = 11.8 mW/g

**Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

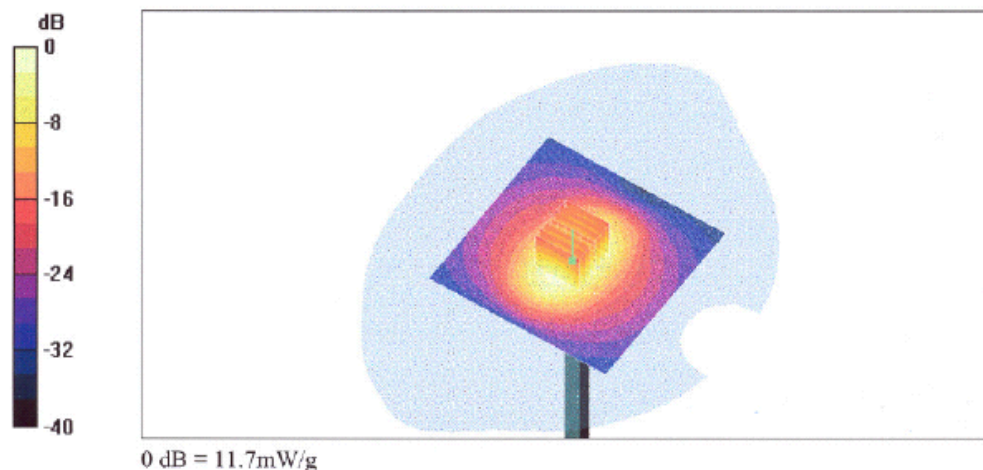
Peak SAR (extrapolated) = 18.7 W/kg

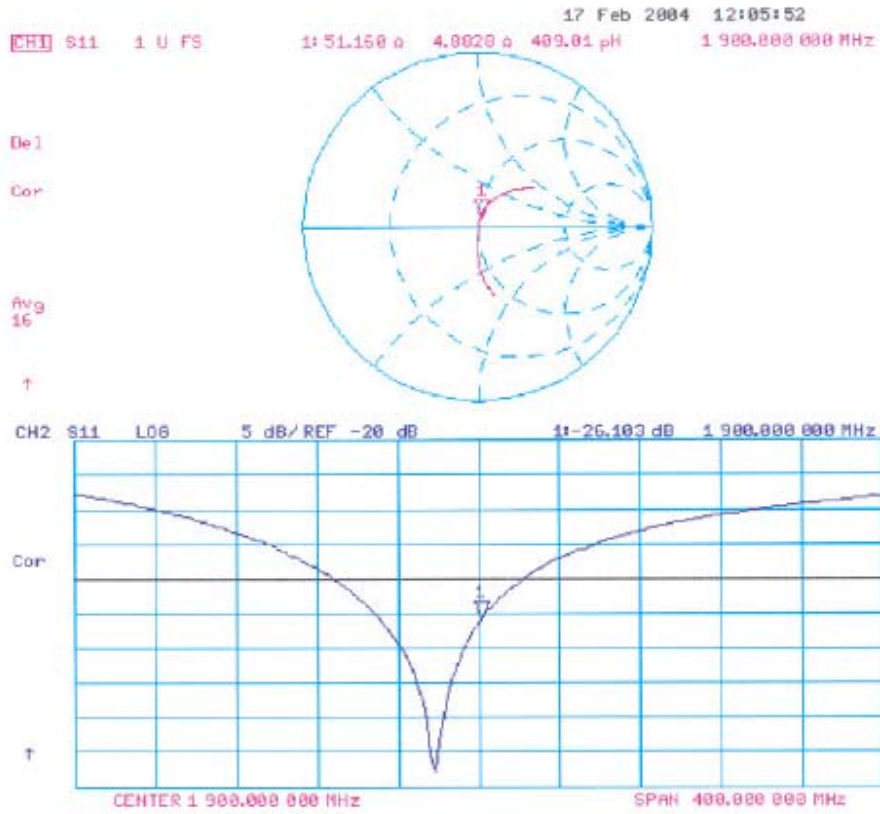
**SAR(1 g) = 10.4 mW/g; SAR(10 g) = 5.39 mW/g**

Reference Value = 93.8 V/m

Power Drift = 0.002 dB

Maximum value of SAR = 11.7 mW/g







Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN5d041**

Communication System: CW-1900; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: Muscle 1900 MHz;

Medium parameters used:  $f = 1900$  MHz;  $\sigma = 1.58$  mho/m;  $\epsilon_r = 52.5$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: Flat Section

Measurement Standard: DASy4 (High Precision Assessment)

DASy4 Configuration:

- Probe: ET3DV6 - SN1507; ConvF(4.57, 4.57, 4.57); Calibrated: 1/23/2004
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE3 - SN411; Calibrated: 11/6/2003
- Phantom: SAM with CRP - TP1006; Type: SAM 4.0; Serial: TP:1006;
- Measurement SW: DASy4, V4.2 Build 25; Postprocessing SW: SEMCAD, V1.8 Build 101

**Pin = 250 mW; d = 10 mm/Area Scan (81x81x1):** Measurement grid: dx=15mm, dy=15mm

Reference Value = 92.6 V/m; Power Drift = 0.0 dB

Maximum value of SAR (interpolated) = 11.8 mW/g

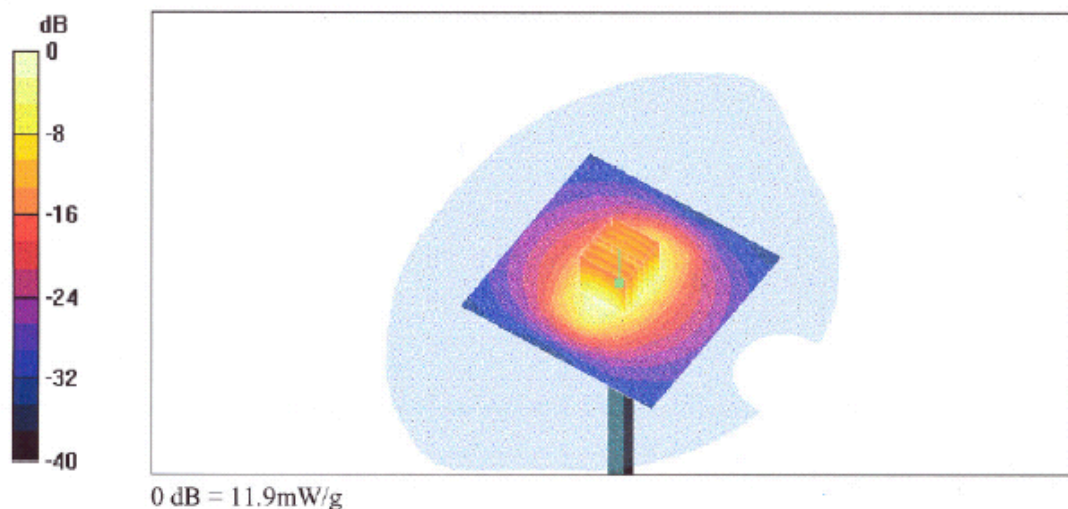
**Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

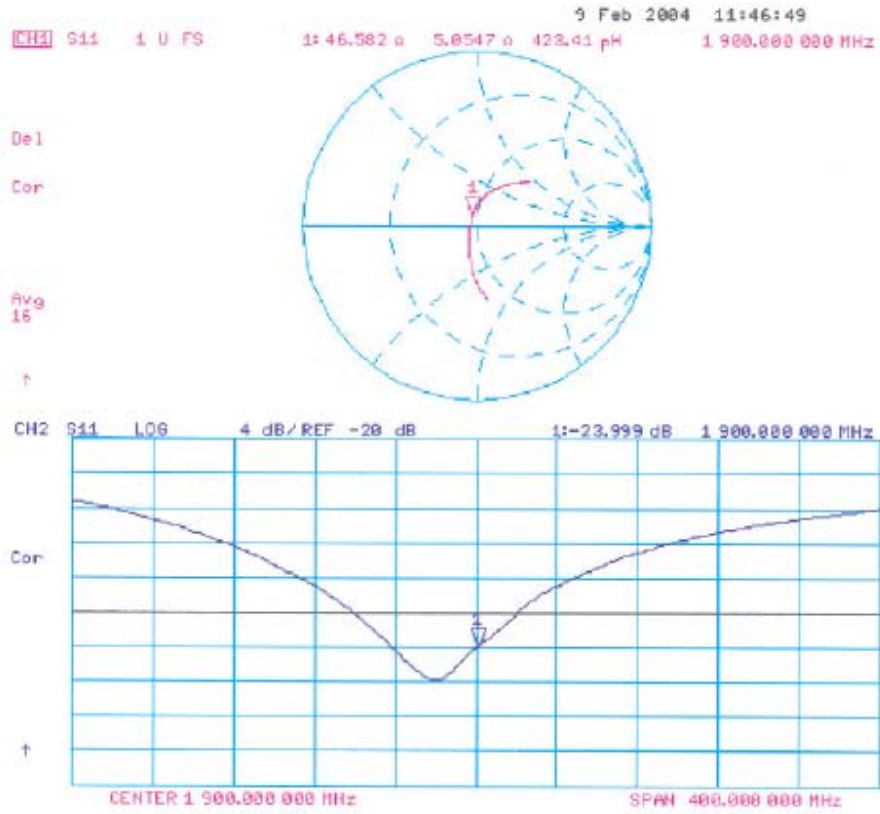
Reference Value = 92.6 V/m; Power Drift = 0.0 dB

Maximum value of SAR (measured) = 11.9 mW/g

Peak SAR (extrapolated) = 18.8 W/kg

SAR(1 g) = 10.5 mW/g; SAR(10 g) = 5.49 mW/g







Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
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Accreditation No.: SCS 108

Client Sporton (Auden)

Certificate No: ET3-1788\_Sep04

CALIBRATION CERTIFICATE

Object ET3DV6 - SN:1788
Calibration procedure(s) QA CAL-01.v5 Calibration procedure for dosimetric E-field probes
Calibration date: September 30, 2004
Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Table with 4 columns: Primary Standards, ID #, Cal Date (Calibrated by, Certificate No.), Scheduled Calibration. Lists equipment like Power meter E4419B, Reference 3 dB Attenuator, etc.

Table with 4 columns: Secondary Standards, ID #, Check Date (in house), Scheduled Check. Lists equipment like Power sensor HP 8481A, RF generator HP 8648C, etc.

Calibrated by: Nico Vetterli, Laboratory Technician
Approved by: Katja Pokovic, Technical Manager

Issued: October 1, 2004

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.



Calibration Laboratory of  
Schmid & Partner  
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Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 108

**Glossary:**

TSL	tissue simulating liquid
NORM <sub>x,y,z</sub>	sensitivity in free space
ConF	sensitivity in TSL / NORM <sub>x,y,z</sub>
DCP	diode compression point
Polarization $\phi$	$\phi$ rotation around probe axis
Polarization $\vartheta$	$\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

**Calibration is Performed According to the Following Standards:**

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001

**Methods Applied and Interpretation of Parameters:**

- *NORM<sub>x,y,z</sub>*: Assessed for E-field polarization  $\vartheta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). *NORM<sub>x,y,z</sub>* are only intermediate values, i.e., the uncertainties of *NORM<sub>x,y,z</sub>* does not effect the  $E^2$ -field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)<sub>x,y,z</sub>* = *NORM<sub>x,y,z</sub>* \* *frequency\_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCP<sub>x,y,z</sub>*: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- *ConvF and Boundary Effect Parameters*: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORM<sub>x,y,z</sub>* \* *ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY 4.3 B17 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- *Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



ET3DV6 SN:1788

September 30, 2004

# Probe ET3DV6

## SN:1788

Manufactured:	May 28, 2003
Last calibrated:	August 29, 2003
Recalibrated:	September 30, 2004

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)



ET3DV6 SN:1788

September 30, 2004

**DASY - Parameters of Probe: ET3DV6 SN:1788**

Sensitivity in Free Space<sup>A</sup>

Diode Compression<sup>B</sup>

NormX	1.68 ± 9.9%	$\mu V/(V/m)^2$	DCP X	94 mV
NormY	1.70 ± 9.9%	$\mu V/(V/m)^2$	DCP Y	94 mV
NormZ	1.74 ± 9.9%	$\mu V/(V/m)^2$	DCP Z	94 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL                    900 MHz    Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR <sub>be</sub> [%]	Without Correction Algorithm	8.1	4.4
SAR <sub>be</sub> [%]	With Correction Algorithm	0.7	0.1

TSL                    1810 MHz    Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR <sub>be</sub> [%]	Without Correction Algorithm	12.0	8.2
SAR <sub>be</sub> [%]	With Correction Algorithm	0.9	0.1

Sensor Offset

Probe Tip to Sensor Center                    2.7 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the E<sup>2</sup>-field uncertainty inside TSL (see Page 8).

<sup>B</sup> Numerical linearization parameter: uncertainty not required.



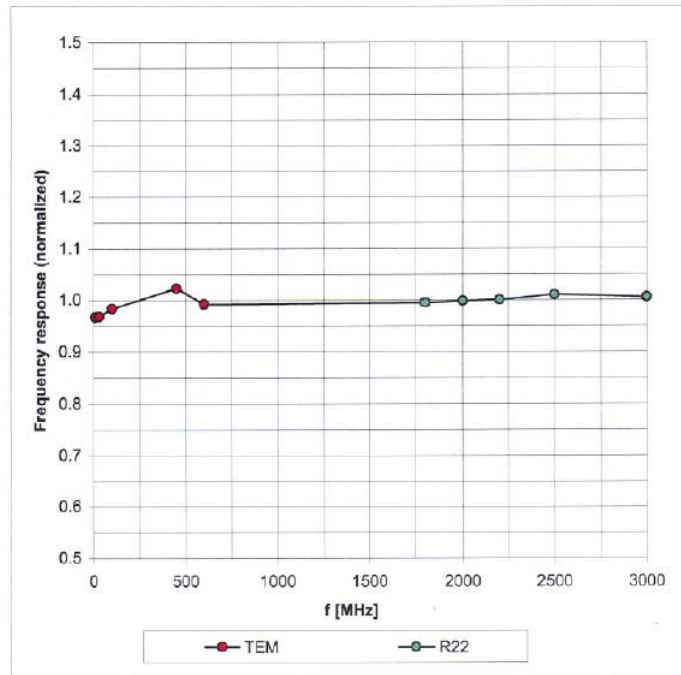


ET3DV6 SN:1788

September 30, 2004

### Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



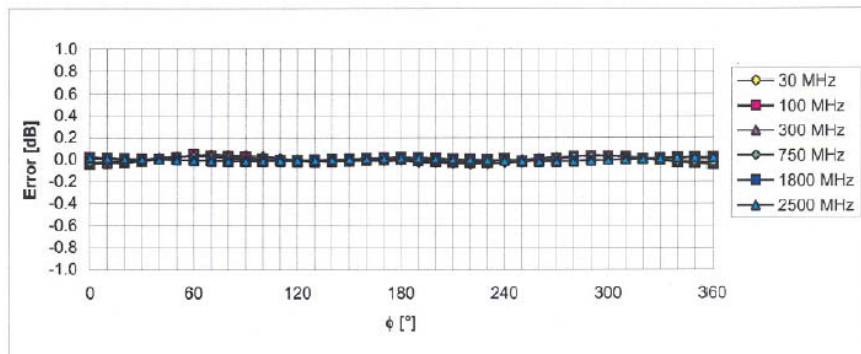
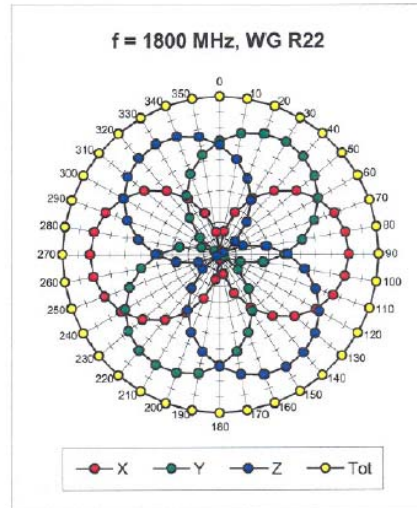
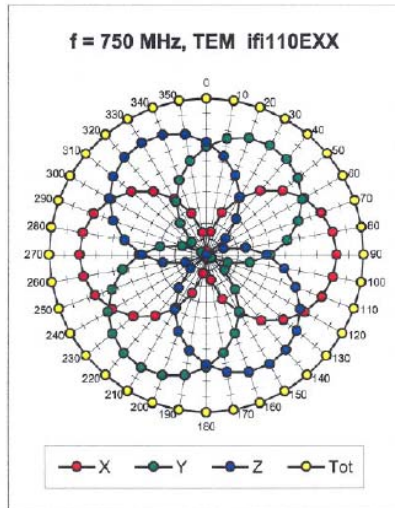
Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  ( $\kappa=2$ )



ET3DV6 SN:1788

September 30, 2004

### Receiving Pattern ( $\phi$ ), $\theta = 0^\circ$



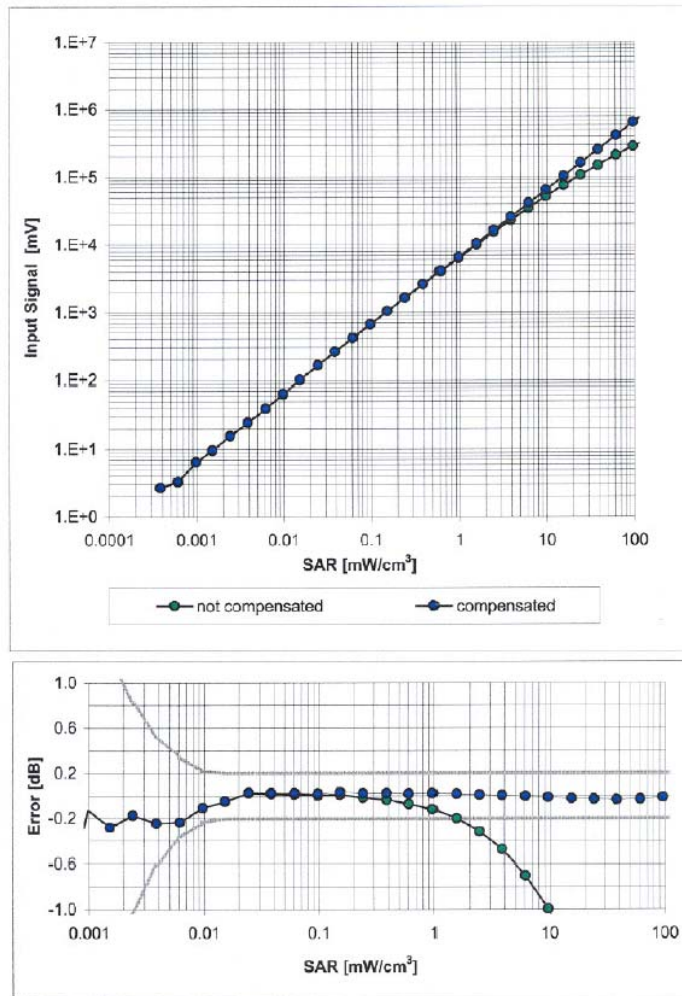
Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )



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September 30, 2004

### Dynamic Range f(SAR<sub>head</sub>) (Waveguide R22, f = 1800 MHz)



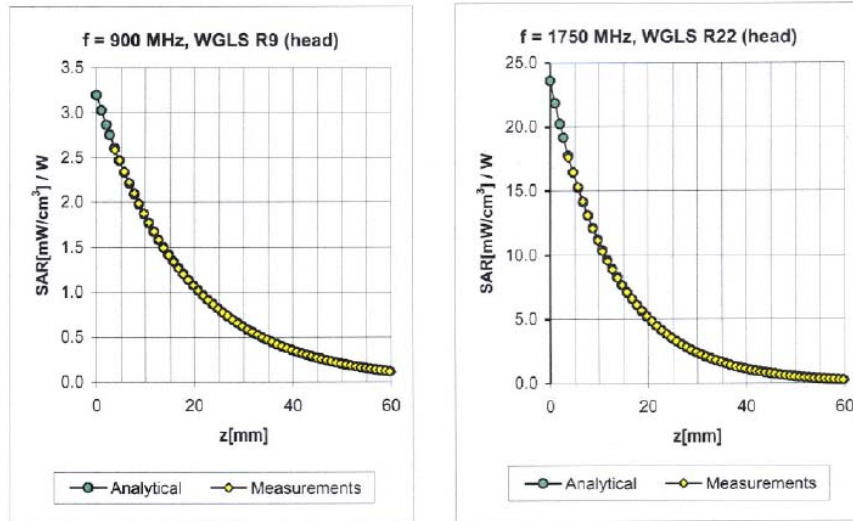
Uncertainty of Linearity Assessment: ± 0.6% (k=2)



ET3DV6 SN:1788

September 30, 2004

### Conversion Factor Assessment



f [MHz]	Validity [MHz] <sup>c</sup>	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	1.12	1.42	6.74 ± 11.0% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	1.07	1.44	6.63 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.56	2.31	5.37 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.55	2.42	5.16 ± 11.0% (k=2)
2000	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.54	2.59	4.88 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.65	2.22	4.56 ± 11.8% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	1.04	1.52	6.53 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.99	1.56	6.17 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.53	2.74	4.73 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.55	2.82	4.56 ± 11.0% (k=2)
2000	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.54	2.98	4.43 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.72	2.00	4.26 ± 11.8% (k=2)

<sup>c</sup> The validity of ± 100 MHz only applies for DASY 4.3 B17 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

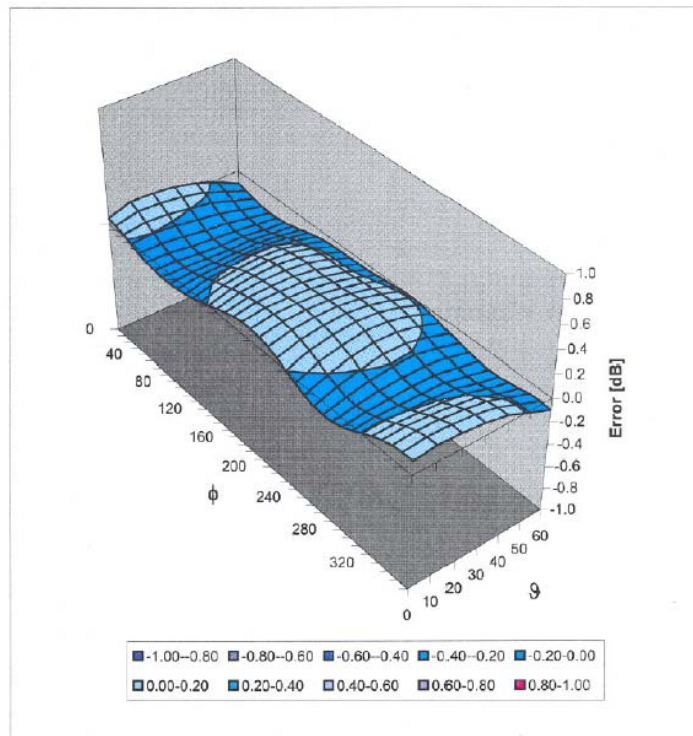


ET3DV6 SN:1788

September 30, 2004

### Deviation from Isotropy in HSL

Error ( $\phi, \theta$ ),  $f = 900$  MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )



Calibration Laboratory of  
Schmid & Partner  
Engineering AG  
Zeughausstrasse 43, 8004 Zurich, Switzerland

Client **Sporton (Auden)**

CALIBRATION CERTIFICATE			
Object(s)	DAE3 – SD 000 D03 AA – SN:577		
Calibration procedure(s)	QA CAL-06.v4 Calibration procedure for the data acquisition unit (DAE)		
Calibration date:	21.11.2003		
Condition of the calibrated item	In Tolerance (according to the specific calibration document)		
This calibration statement documents traceability of M&TE used in the calibration procedures and conformity of the procedures with the ISO/IEC 17025 international standard.			
All calibrations have been conducted in the closed laboratory facility environment temperature 22 +/- 2 degrees Celsius and humidity < 75%.			
Calibration Equipment used (M&TE critical for calibration)			
Model Type	ID #	Cal Date	Scheduled Calibration
Fluke Process Calibrator Type 702	SN. 6295803	8-Sep-03	Sep-05
Calibrated by:	Name Philipp Storchenegger	Function Technician	Signature 
Approved by:	Name Fin Bomholt	Function R&D Director	Signature 
Date issued 21.11.2003			
This calibration certificate is issued as an intermediate solution until the accreditation process (based on ISO/IEC 17025 International Standard) for Calibration Laboratory of Schmid & Partner Engineering AG is completed.			



DAE3 SN: 577

DATE: 21.11.2003

**1. Cal Lab. Incoming Inspection & Pre Test**

<b>Modification Status</b>	Note Status here → → → →	BC
<b>Visual Inspection</b>	Note anomalies.....	None
	.....	.....
<b>Pre Test</b>	<b>Indication</b>	<b>Yes/No</b>
<b>Probe Touch</b>	Function	Yes
<b>Probe Collision</b>	Function	Yes
<b>Probe Touch&amp;Collision</b>	Function	Yes

**2. DC Voltage Measurement**

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1µV , full range = 400 mV  
 Low Range: 1LSB = 61nV , full range = 4 mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.434	403.889	404.352
Low Range	3.94303	3.94784	3.9501
Connector Angle to be used in DASY System	127 °		

High Range	Input	Reading in µV	% Error
Channel X + Input	200mV	200000.6	0.00
	20mV	20000.9	0.00
Channel X - Input	20mV	-19992.7	-0.04
Channel Y + Input	200mV	200000.6	0.00
	20mV	19999.1	0.00
Channel Y - Input	20mV	-19994.7	-0.03
Channel Z + Input	200mV	199999.8	0.00
	20mV	19998.1	-0.01
Channel Z - Input	20mV	-19999.2	0.00

Low Range	Input	Reading in µV	% Error
Channel X + Input	2mV	1999.94	0.00
	0.2mV	199.08	-0.46
Channel X - Input	0.2mV	-200.24	0.12
Channel Y + Input	2mV	1999.98	0.00
	0.2mV	199.50	-0.25
Channel Y - Input	0.2mV	-200.80	0.40
Channel Z + Input	2mV	1999.98	0.00
	0.2mV	199.11	-0.44
Channel Z - Input	0.2mV	-201.12	0.56



DAE3 SN: 577

DATE: 21.11.2003

**3. Common mode sensitivity**

DASY measurement parameters:

Auto Zero Time: 3 sec,

Measuring time: 3 sec

High/Low Range

in $\mu\text{V}$	Common mode Input Voltage	High Range Reading	Low Range Reading
Channel X	200mV	12.00	11.9
	- 200mV	-10.76	-12.44
Channel Y	200mV	-8.55	-8.51
	- 200mV	7.58	6.67
Channel Z	200mV	-0.86	-0.58
	- 200mV	-0.85	-0.77

**4. Channel separation**

DASY measurement parameters:

Auto Zero Time: 3 sec,

Measuring time: 3 sec

High Range

in $\mu\text{V}$	Input Voltage	Channel X	Channel Y	Channel Z
Channel X	200mV	-	1.96	0.28
Channel Y	200mV	0.66	-	3.59
Channel Z	200mV	-0.89	-0.11	-

**5.1 AD-Converter Values with Input Voltage set to 2.0 VDC**

in Zero Low	Low Range Max - Min	Max.	Min
Channel X	17	16137	16120
Channel Y	27	16767	16740
Channel Z	8	15103	15077

**5.2 AD-Converter Values with inputs shorted**

in LSB	Low Range	High Range
Channel X	16134	15955
Channel Y	16740	15960
Channel Z	15093	16252

**6. Input Offset Measurement**





DAE3 SN: 577

DATE: 21.11.2003

DASY measurement parameters:

Auto Zero Time: 3 sec, Measuring time: 3 sec  
Number of measurements: 100, Low Range

Input 10MΩ

in μV	Average	min. Offset	max. Offset	Std. Deviation
Channel X	-0.64	-1.84	0.71	0.49
Channel Y	-1.77	-3.93	0.94	0.58
Channel Z	-2.21	-3.14	-0.81	0.34

Input shorted

in μV	Average	min. Offset	max. Offset	Std. Deviation
Channel X	0.12	-1.34	1.45	0.69
Channel Y	-0.69	-1.39	0.30	0.26
Channel Z	-0.94	-1.58	-0.30	0.23

**7. Input Offset Current**

Nominal Input circuitry offset current on all channels: <25fA

**8. Input Resistance**

In MOhm	Calibrating	Measuring
Channel X	0.2000	197.1
Channel Y	0.1999	200.3
Channel Z	0.2001	198.3

**9. Low Battery Alarm Voltage**

in V	Alarm Level
Supply (+ Vcc)	7.58
Supply (- Vcc)	-7.65

**10. Power Consumption**

in mA	Switched off	Stand by	Transmitting
Supply (+ Vcc)	0.00	5.65	13.7
Supply (- Vcc)	-0.01	-7.69	-8.97